Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/663,683	NISHIYAMA ET AL.
Examiner	Art Unit
Yevgeny Valenrod	1621

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
SEE	EAST	٠			
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SEARCH NOT (INCLUDING SEARCH) .
	DATE	EXMR
STIC STN structure/inventor search see transcript	11/1/2006	YV
Inventor search, eDAN, EAST, PALM	10/31/2006	YV
EAST class/subclass + text search, Classes searched: 548/400; 546/305, 315, 322, 326. US-PGPUB; USPAT; USOCR; EPO; JPO; DERW	11/1/2006	YV
Patentability conference with Tom McKenzie	11/1/2006	YV
STN structure search	9/6/2006	YV
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